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June 2016

FDMD84100

Dual N-Channel PowerTrench[®] **MOSFET** 100 V, 21 A, 20 m Ω

Features

- Max $r_{DS(on)} = 20 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 7 \text{ A}$
- Max $r_{DS(on)} = 32 \text{ m}\Omega$ at $V_{GS} = 6 \text{ V}$, $I_D = 5.5 \text{ A}$
- Ideal for flexible layout in secondary side synchronous rectification
- Termination is Lead-free and RoHS Compliant
- 100% UIL tested

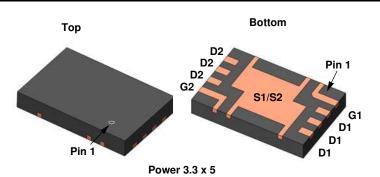
General Description

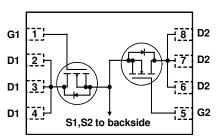
This package integrates two N-Channel devices connected internally in common-source configuration. This enables very low package parasitics and optimized thermal path to the common source pad on the bottom. Provides a very small footprint (3.3 x 5 mm) for higher power density.

Applications

- Isolated DC-DC Synchronous Rectifiers
- Common Ground Load Switches







MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Param	eter		Ratings	Units
V_{DS}	Drain to Source Voltage			100	V
V_{GS}	Gate to Source Voltage			±20	V
I _D	Drain Current -Continuous	T _C = 25 °C		21	
	-Continuous	T _A = 25 °C	(Note 1a)	7	Α
	-Pulsed		(Note 4)	80	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	121	mJ
P _D	Power Dissipation	T _C = 25 °C		23	W
	Power Dissipation	T _A = 25 °C	(Note 1a)	2.1	VV
T _J , T _{STG}	Operating and Storage Junction Tempera	ature Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	5.3	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	60	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
84100	FDMD84100	Power 3.3 x 5	13 "	12 mm	3000 units

Electrical Characteristics T_J = 25 °C unless otherwise noted

Symbol	Parameter Test Conditions		Min	Тур	Max	Units
Off Chara	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	100			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		74		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 80 V, V _{GS} = 0 V			1	μА
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA

On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2	3.1	4	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		-9		mV/°C
		V _{GS} = 10 V, I _D = 7 A		16	20	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 6 \text{ V}, I_D = 5.5 \text{ A}$		24	32	$m\Omega$
, ,		$V_{GS} = 10 \text{ V}, I_D = 7 \text{ A}, T_J = 125 \text{ °C}$		30	38	
9 _{FS}	Forward Transconductance	$V_{DD} = 5 \text{ V}, \ I_{D} = 7 \text{ A}$		17		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 50 V V 0 V		734	980	pF
Coss	Output Capacitance	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}$		168	225	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 101112		6.6	15	pF
R_{α}	Gate Resistance		0.1	1.3	3	Ω

Switching Characteristics

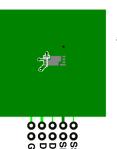
t _{d(on)}	Turn-On Delay Time		$V_{DD} = 50 \text{ V}, I_{D} = 7 \text{ A}$ $V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$		8.4	17	ns
t _r	Rise Time	V _{DD} = 50 V, I _D = 7 A			2.6	10	ns
t _{d(off)}	Turn-Off Delay Time	V _{GS} = 10 V, R _{GEN} =			14	25	ns
t _f	Fall Time				2.8	10	ns
0	Total Gate Charge	V _{GS} = 0 V to 10 V	V _{GS} = 0 V to 10 V		11	16	nC
$Q_{g(TOT)}$	Total Gate Charge	$V_{GS} = 0 \text{ V to 6 V}$	$V_{DD} = 50 \text{ V}$		7.3	11	nC
Q_{gs}	Gate to Source Charge	I	_D = 7 A		3.4		nC
Q_{gd}	Gate to Drain "Miller" Charge				2.5		nC

Drain-Source Diode Characteristics

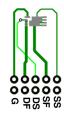
V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = 7 A$ (Note 2)	0.8	1.2	V
t _{rr}	Reverse Recovery Time	I _E = 7 A, di/dt = 100 A/μs	43	70	ns
Q _{rr}	Reverse Recovery Charge	$IF = 7 \text{ A}$, $di/dt = 100 \text{ A/}\mu\text{S}$	44	71	nC

NOTES

^{1.} R_{0JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



a. 60 °C/W when mounted on a 1 in² pad of 2 oz copper



b.160 °C/W when mounted on a minimum pad of 2 oz copper

^{2.} Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0 %.

^{3.} E_{AS} of 121 mJ is based on starting T_J = 25 °C, L = 3 mH, I_{AS} = 9 A, V_{DD} = 100 V, V_{GS} = 10 V. 100% tested at L = 0.1 mH, I_{AS} = 30 A.

^{4.} Pulse Id refers to Figure.11 Forward Bias Safe Operation Area.

Typical Characteristics T_J = 25 °C unless otherwise noted

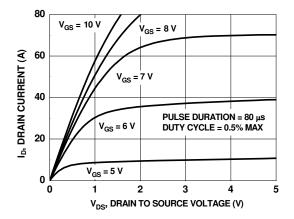


Figure 1. On-Region Characteristics

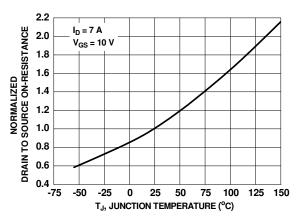


Figure 3. Normalized On-Resistance vs Junction Temperature

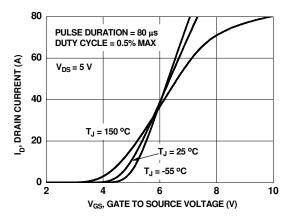


Figure 5. Transfer Characteristics

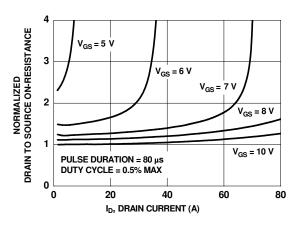


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

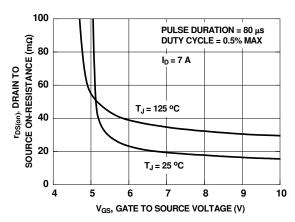


Figure 4. On-Resistance vs Gate to Source Voltage

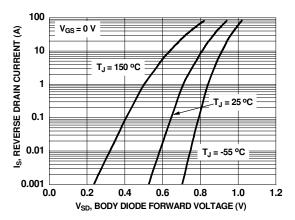


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

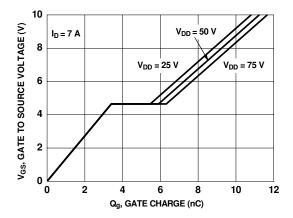


Figure 7. Gate Charge Characteristics

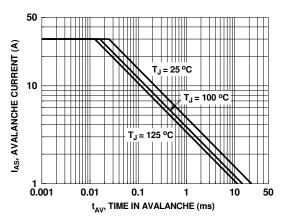


Figure 9. Unclamped Inductive Switching Capability

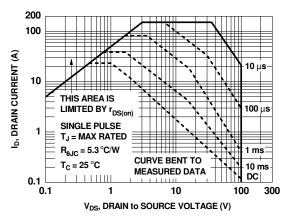


Figure 11. Forward Bias Safe Operating Area

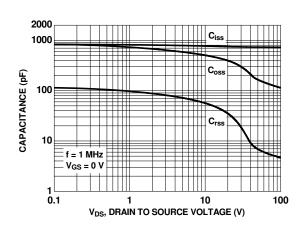


Figure 8. Capacitance vs Drain to Source Voltage

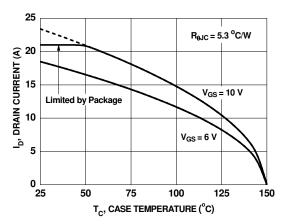


Figure 10. Maximum Continuous Drain Current vs Case Temperature

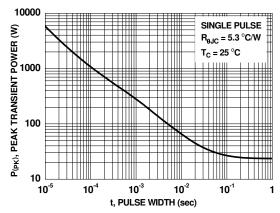
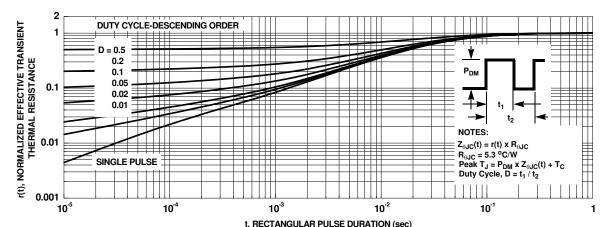
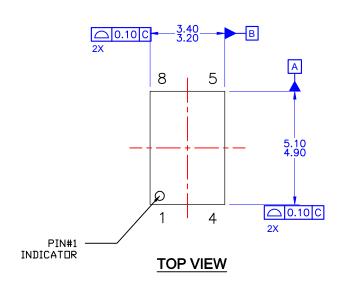


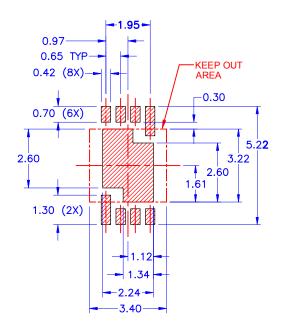
Figure 12. Single Pulse Maximum Power Dissipation

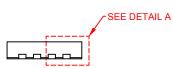




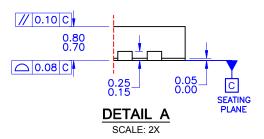
t, RECTANGULAR PULSE DURATION (sec)
Figure 13. Junction-to-Case Transient Thermal Response Curve



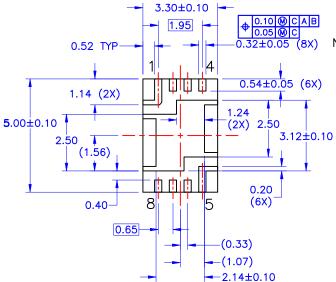




FRONT VIEW



LAND PATTERN RECOMMENDATION



NOTES: UNLESS OTHERWISE SPECIFIED

- A) DOES NOT FULLY CONFORM TO JEDEC REGISTRATION, MO229 DATED 8/2012.
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
- D) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
- E) IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.
- F) DRAWING FILE NAME: MKT-PQFN08NREV1.

BOTTOM VIEW

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